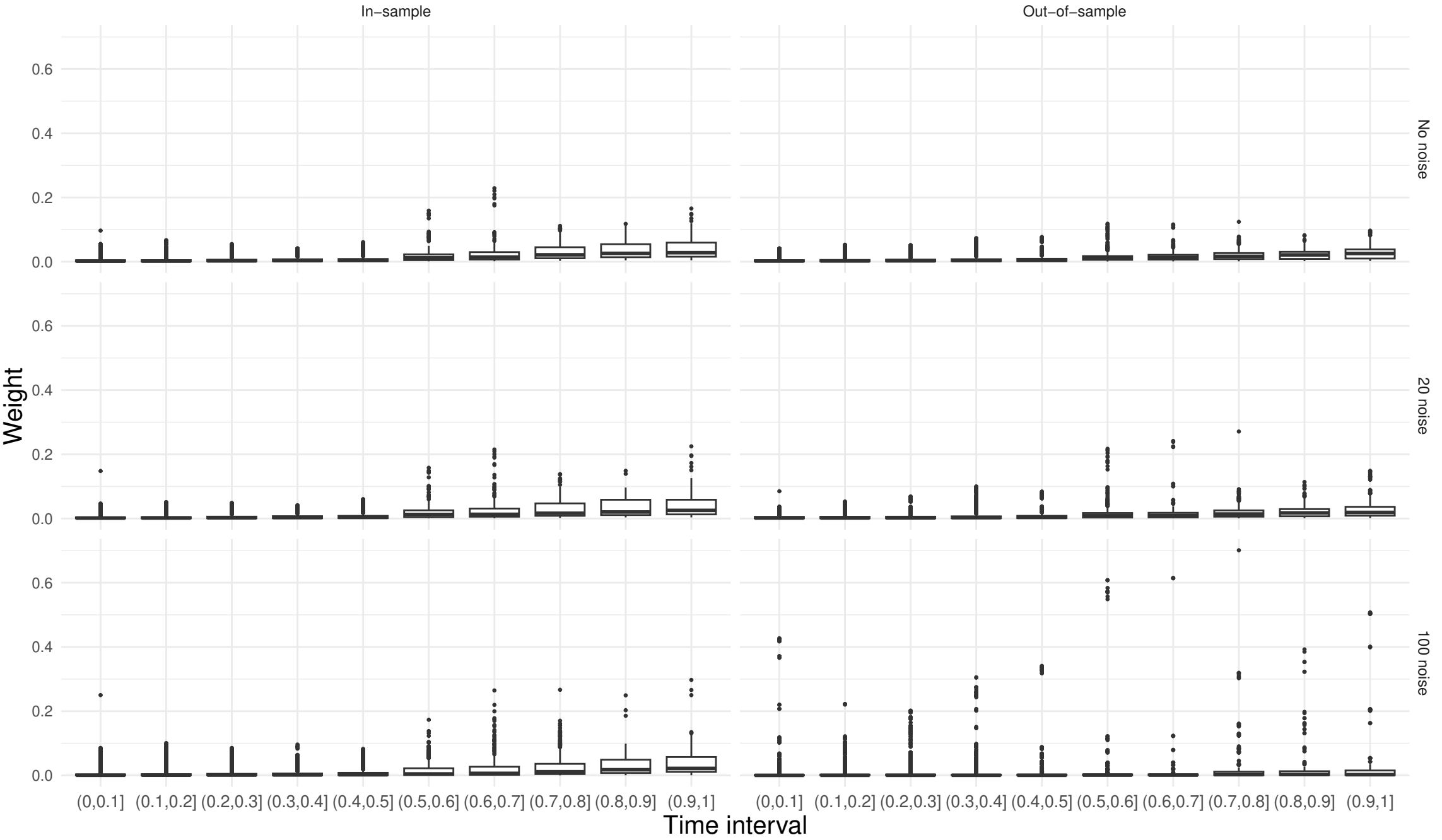
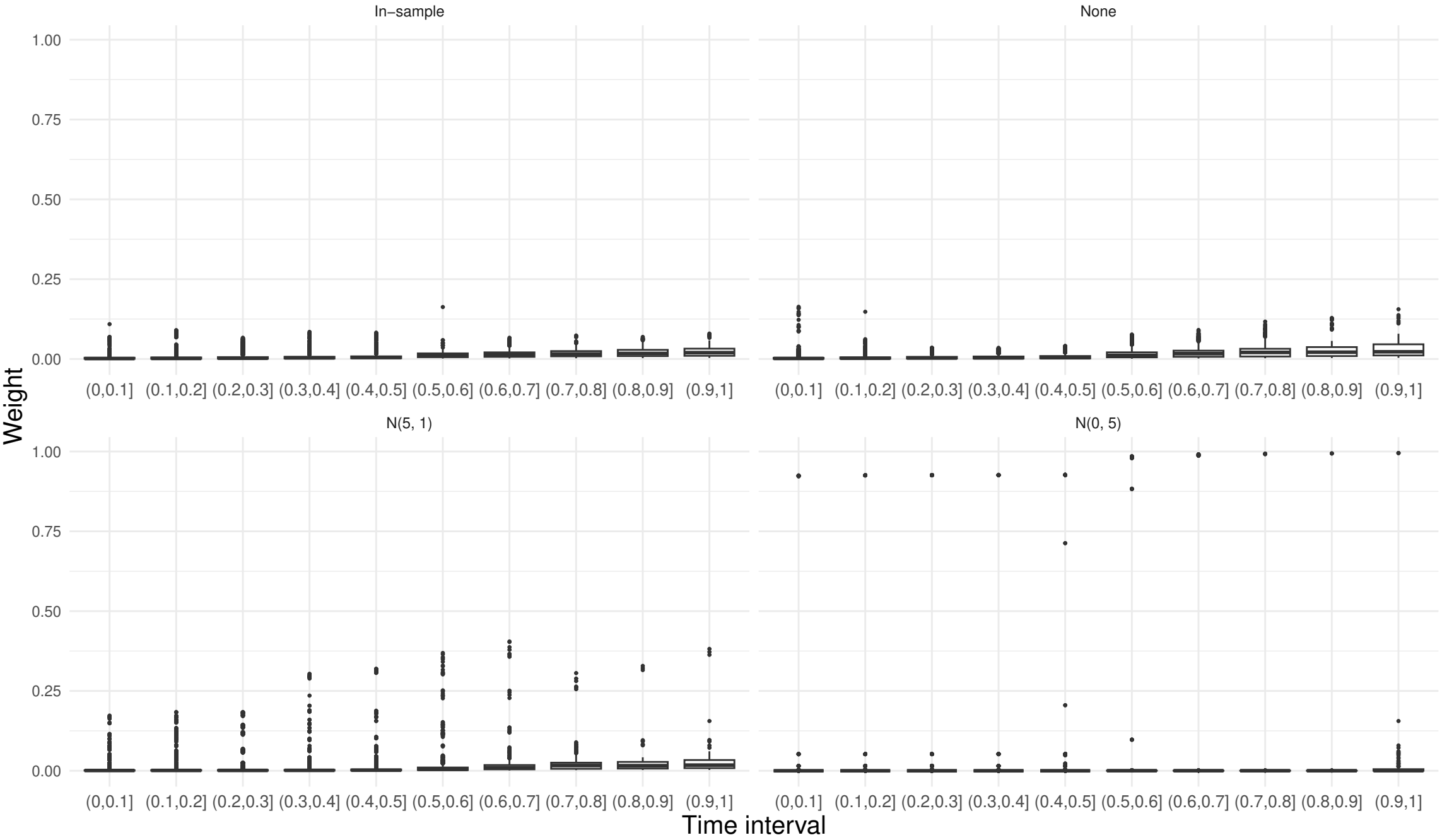
(a). Model overfit



(b). Data contamination